HYDROSTATIC PRESSURE AND UNIAXIAL 11 4-1 STRESS DEPENDENCE OF THE SILICON (222) X-RAY REFLECTION POWER. By U.Pietsch, Arbeitsgemein-schaft A(III)B(V)-Halbleiter, Karl-Marx-Universität, Leipzig, DDR.

For the interpretation of the silicon bond For the interpretation of the silicon bond charge properties a moleculetheoretic model is introduced (Pietsch, phys.stat.sol.(b), 120, 183 (1983)). Both the total valence electron density and the bond charge, respectively, are constructed by superposition of diatomic molecule densities. Each molecule contains a molecule densities. Each molecule contains an individual overlap charge. The coefficients of the Gaussian like /stsp3> model wave functions are fitted to the known valence electron density of the solid state. The bond charge amount depends on both the variation of the next neighbour distance AR and the charging of the bond angles . A

and the changing of the bond angles A9,

and the changing of the bond dependence of the respectively. The hydrostatic pressure dependence of the silicon (222) reflection power was published by D.R.Yoder-Short et.al.(Phys.Rev.Lett 149, 1438 (1982)). Using the above model the increased reflection power up to 10 GPa is described by the bond length dependence of the overlap charge. The coefficients of the described by the bond length dependence of the overlap charge. The coefficients of the model valence orbitals remain constant. The following decreasing of the (222) intensity up to the phase transition point at 12.5 GPa is interpreted by an increasing of the /s> portion at the model wave function. After the precise determination of the internal strain parameter by H.D'Amour et. al.(J. Appl.Cryst. 15, 148 (1982)) and C.S.G. Cousins et. al.(J.Appl.Cryst. 15, 154(1982)) the analysis of the uniaxial strain dependence of the bond charge is of interest. The of the bond charge is of interest. The variation of the "forbidden" reflection powers for [001] and [011] stress are calculated with for [001] and [011] stress are calculated with respect to the /p> portions of the model valence orbitals.For [001] stress, for instance, the (222) reflection intensity must decrease according to both the variation of the next neighbour distance and the changing of the bond angles, respectively. Neglecting the bond angle depended part a generally increased (222) reflection power will be found. Therefore, these experiments would give a direct indication of the /p> like portions of the covalent bond in elemental semiconductors. The Debye-Waller factor is no longer a mere correction factor for diffraction intensities. It has emerged as an independent solid state parameter capable of providing a wide range of information about the crystal.

This laboratory has on hand an extensive programme on the X-ray determination of Debye-Waller factors of crystals. Using a powder diffractometer, twenty crystals. Using a powder diffractometer, twenty crystals with NaCl structure, nine with CsCl structure and five with CaF_2 structure have been investi-gated so far. These include ionic crystals, refractory with care and a structure. refractory materials and rare earth com-pounds. The results are presented.

Apart from yielding values of amplitudes of vibrations and Debye temperatures, the Debye-Waller factors have provided interesting information regarding such aspects as the interatomic binding, the effect of mass ratio and electron environment on atomic vibration amplitudes and thermal defects in these crystals, some of which are discussed.

11.4 - 3GENERALIZED VIRIAL APPROACH IN THE CRYSTALLINE STATE THEORY. By V.K.Pershin.Ural Polytechnical Institute,620002 Sverdlovsk,USSR

The infinite "linear" equations system $\sum_{ij\vec{p}} x_{\vec{s}j}^{si}(\vec{n},\vec{p}) R_{j\vec{p}}^{ig}(\vec{p},\vec{m}) = kT \delta_{sg} \delta_{\vec{s}\vec{p}} \delta_{\vec{n}\vec{m}} ,$ where $x_{\vec{s}j}^{si}(\vec{n},\vec{p}) = \langle u_{\vec{s}}^{s}(\vec{n}) u_{j}^{i}(\vec{p}) \rangle$ and $R_{j\vec{p}}^{ig}(\vec{p},\vec{m}) = \langle \partial^{2}U/\partial u_{j}^{i}(\vec{p}) \partial u_{\vec{p}}^{g}(\vec{m}) \rangle$, is obtained at the pseudoharmonic approximation by use of the generali-zed form of the uniform distribution theorem as following

as ioiiowing $\langle u_{\alpha}^{\rm S}(\vec{n}) \partial U / \partial u_{\beta}^{\rm S}(\vec{m}) \rangle = kT \delta_{\rm Sg} \delta_{\alpha\beta} \delta_{\vec{n}\vec{m}},$ where $u_{\alpha}^{\rm S}(\vec{n})$ is the displacement α -component of

the particle s from the equilibrium position in the knot with the radius-vector $\mathbf{\tilde{n}}$;U is the In the knot with the radius-vector n; U is the potential crystal energy; T is the absolute temperature. On the basis of the correlations weakening theorem for threedimensional systems it is proved that this system has a single so-lution. It is shown that Kramer's rules are ap-plicable for the solution of the virial equa-tions system. The spectral theorem matrix for-pulation allowing to represent any neuroper mulation allowing to represent any pair corre-lation function in the dependence on the lattice force constants and to determine the con-tribution of each of them into the value of this function is given. The developed approach being a new mathematical version of the selfconsistent field theory allows to investigate the structural dynamic crystal state without the analysis of the own vibration spectrum of the lattice and the integration over the kspace.